

Search Notes

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Examiner

Bin Shen

Applicant(s)/Patent under
Reexamination

JANG ET AL.

Art Unit

1657

SEARCHED

Class	Subclass	Date	Examiner
NA	NA	5/10/2007	BS

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN/STIC-see printout.	5/10/2007	BS
Priority document checked.	5/10/2007	BS
Inventor name search.	5/10/2007	BS
SEQ search: NA.	5/10/2007	BS